TOSHIBA Field Effect Transistor Silicon N Channel MOS Type (π-MOSV)

2SK3388

Switching Regulator and DC-DC Converter Applications Motor Drive Applications

• Low drain-source ON resistance: $RDS(ON) = 82 \text{ m}\Omega \text{ (typ.)}$

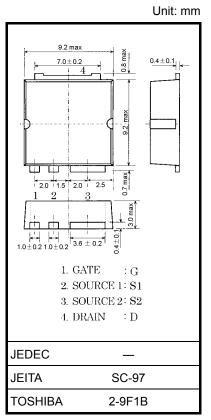
• High forward transfer admittance: $|Y_{fs}| = 20 \text{ S (typ.)}$

• Low leakage current: $I_{DSS} = 100 \,\mu\text{A} \,(V_{DS} = 250 \,\text{V})$

• Enhancement mode: $V_{th} = 1.5 \text{ to } 3.5 \text{ V (V}_{DS} = 10 \text{ V, I}_{D} = 1 \text{ mA)}$

Absolute Maximum Ratings (Ta = 25°C)

Characteristics		Symbol	Rating	Unit	
Drain-source voltage		V_{DSS}	250	V	
Drain-gate voltage ($R_{GS} = 20 \text{ k}\Omega$)		V_{DGR}	250	V	
Gate-source voltage		V _{GSS}	±20	V	
Drain current	DC (Note 1)	I _D	20	А	
	Pulse (Note 1)	I _{DP}	60		
Drain power dissipation (Tc = 25°C)		P _D	125	W	
Single pulse avalanche energy (Note 2)		E _{AS}	487	mJ	
Avalanche current		I _{AR}	20	Α	
Repetitive avalanche energy (Note 3)		E _{AR}	12.5	mJ	
Channel temperature		T _{ch}	150	°C	
Storage temperature range		T _{stg}	-55~150	°C	



Weight: 0.74 g (typ.)

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings. Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/Derating Concept and Methods) and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

Thermal Characteristics

Characteristics	Symbol	Max	Unit
Thermal resistance, channel to case	R _{th (ch-c)}	1.00	°C/W

Note 1: Ensure that the channel temperature does not exceed 150°C.

Note 2: $V_{DD} = 50 \text{ V}$, $T_{ch} = 25^{\circ}\text{C}$ (initial), L = 2.06 mH, $I_{AR} = 20 \text{ A}$, $R_G = 25 \Omega$

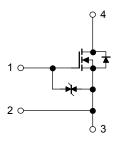
Note 3: Repetitive rating: pulse width limited by maximum channel temperature

This transistor is an electrostatic-sensitive device. Please handle with caution.

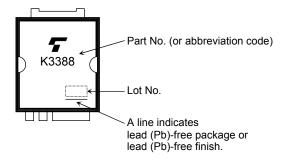
Circuit Configuration

Notice:

Please use the S1 pin for gate input signal return. Make sure that the main current flows into the S2 pin.



Marking



Electrical Characteristics (Note 4) (Ta = 25°C)

Ch	aracteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage cui	rrent	I _{GSS}	$V_{GS} = \pm 16 \text{ V}, V_{DS} = 0 \text{ V}$	_	_	±10	μА
Drain cut-off curr	ent	I _{DSS}	V _{DS} = 250 V, V _{GS} = 0 V	_	_	100	μА
Drain-source bre	akdown voltage	V _{(BR) DSS}	$I_D = 10 \text{ mA}, V_{GS} = 0 \text{ V}$	250	_	_	V
Gate threshold v	oltage	V _{th}	V _{DS} = 10 V, I _D = 1 mA	1.5	_	3.5	V
Drain-source ON	resistance	R _{DS} (ON)	V _{GS} = 10 V, I _D = 10 A	_	82	105	mΩ
Forward transfer	admittance	Y _{fs}	V _{DS} = 10 V, I _D = 10 A	10	20	_	S
Input capacitance		C _{iss}		_	4000	_	pF
Reverse transfer capacitance		C _{rss}	V _{DS} = 10 V, V _{GS} = 0 V, f = 1 MHz	_	300	_	
Output capacitance		Coss		_	1000	_	
Switching time	Rise time	t _r	V _{GS} 10 V I _D = 10 A V _{OUT}	_	7	_	
	Turn-on time	t _{on}		_	20	_	
	Fall time	t _f		_	25	_	ns
	Turn-off time	t _{off}	$V_{DD} \simeq 125 \text{ V}$ Duty \leq 1%, $t_W = 10 \mu\text{s}$	_	145	_	
Total gate charge (gate-source plus gate-drain)		Qg	V _{DD} ≈ 200 V, V _{GS} = 10 V,	_	100	_	nC
Gate-source charge		Q _{gs}	$I_D = 20 \text{ A}$	_	70	_	
Gate-drain ("miller") charge		Q _{gd}		_	30	_	

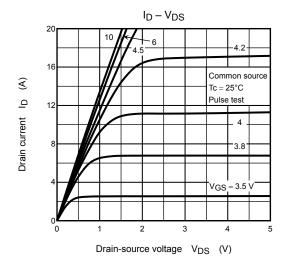
Note 4: Connect the S1 and S2 pins together, and ground them except during switching time measurement.

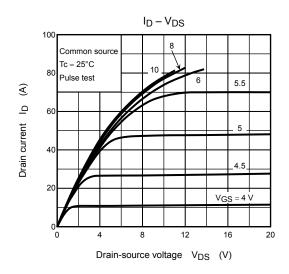
Source-Drain Ratings and Characteristics (Note 5) (Ta = 25°C)

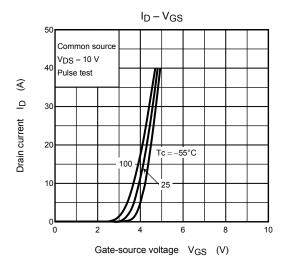
Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Continuous drain reverse current (Note 1, Note 5)	I _{DR} 1	_	_	_	20	А
Pulse drain reverse current (Note 1, Note 5)	I _{DRP} 1	_	_	_	60	Α
Continuous drain reverse current (Note 1, Note 5)	I _{DR} 2	_	_	_	1	Α
Pulse drain reverse current (Note 1, Note 5)	I _{DRP} 2	_	_	_	4	Α
Forward voltage (diode)	V _{DS2F}	I _{DR1} = 20 A, V _{GS} = 0 V	_	_	-2.0	V
Reverse recovery time	t _{rr}	I _{DR} = 20 A, V _{GS} = 0 V,	_	300	_	ns
Reverse recovery charge	Q _{rr}	dl _{DR} /dt = 100 Å/μs	_	3.3	_	μС

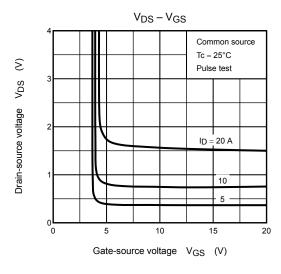
Note 5: $I_{DR}1$, $I_{DRP}1$:Current flowing between the drain and the S2 pin. Ensure that the S1 pin is left open. $I_{DR}2$, $I_{DRP}2$:Current flowing between the drain and the S1 pin. Ensure that the S2 pin is left open.

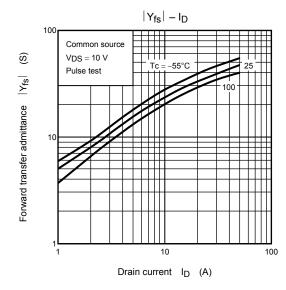
Unless otherwise specified, connect the S1 and S2 pins together, and ground them.

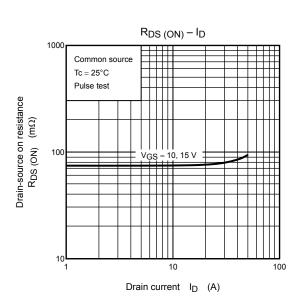




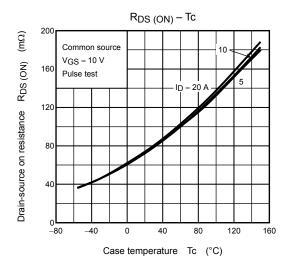


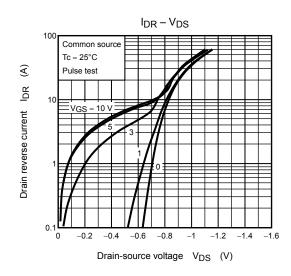


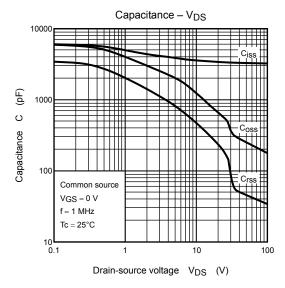


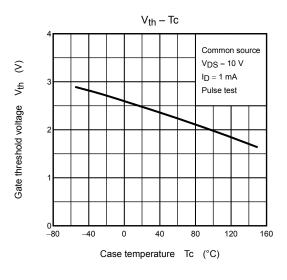


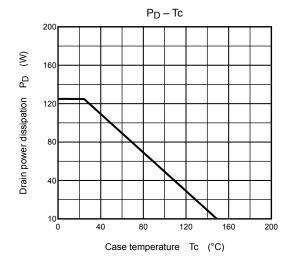
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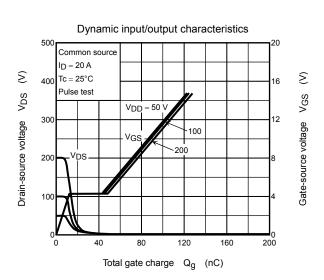


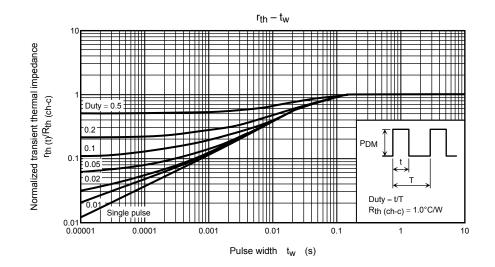


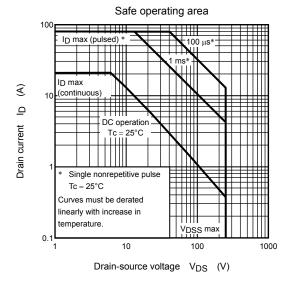


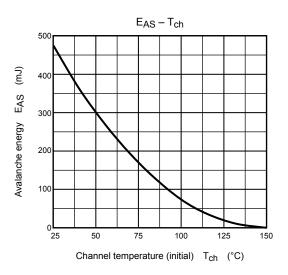


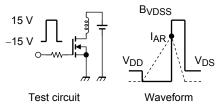












$$\begin{aligned} &R_G = 25~\Omega \\ &V_{DD} = 50~V,~L = 2.06~mH \end{aligned} \qquad EAS = \frac{1}{2} \cdot L \cdot I^2 \cdot \left(\frac{BVDSS}{BVDSS - VDD} \right)$$

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